

Notice of References Cited	Application/Control No. 09/689,548	Applicant(s)/Patent Under Reexamination JOHNSON ET AL.	
	Examiner Brian R. Gordon	Art Unit 1743	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,120,661	10-1978	Naono, Toyohiko	422/100
	B	US-2003/0021734	01-2003	Vann et al.	422/100
	C	US-2002/0192113	12-2002	Uffenheimer et al.	422/67
	D	US-2001/0055545	12-2001	Takii et al.	422/100
	E	US-2001/0053337	12-2001	Doktycz et al.	422/100
	F	US-2001/0026772	10-2001	Fuerst et al.	422/64
	G	US-6,378,556	04-2002	Fondse, Jan Hendrik	137/625.48
	H	US-6,447,678	09-2002	Chau, Yiu Chau	210/266
	I	US-6,322,752	11-2001	Siddiqui et al.	422/100
	J	US-6,158,269	12-2000	Dorenkott et al.	73/37
	K	US-6,066,298	05-2000	Fukunaga, Shingo	422/100
	L	US-6,096,276	08-2000	Laursen, Richard A.	422/103
	M	US-6,040,186	03-2000	Lewis et al.	436/53

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 09/689,548		Applicant(s)/Patent Under Reexamination JOHNSON ET AL.	
	Examiner Brian R. Gordon		Art Unit 1743	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,033,911	03-2000	Schultz et al.	436/49
	B	US-5,849,598	12-1998	Wilson et al.	436/180
	C	US-5,833,925	11-1998	Shu et al.	422/63
	D	US-5,820,824	10-1998	Tanaka, Yosuke	422/100
	E	US-5,601,115	02-1997	Broerman, Arthur B.	137/595
	F	US-5,405,585	04-1995	Coassin, Peter J.	422/100
	G	US-5,578,275	11-1996	Rosenberg et al.	422/163
	H	US-5,250,263	10-1993	Manz, Andreas	422/81
	I	US-4,948,565	08-1990	Bemis et al.	422/103
	J	US-4,818,706	04-1989	Starr, Maurice	436/180
	K	US-4,726,932	02-1988	Feier et al.	422/103
	L	US-4,702,889	10-1987	Cabrera et al.	422/103
	M	US-4,705,627	11-1987	Miwa et al.	210/264

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notic of References Cited	Application/Control No. 09/689,548	Applicant(s)/Patent Under Reexamination JOHNSON ET AL.	
	Examiner Brian R. Gordon	Art Unit 1743	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,694,861	09-1987	Goodale et al.	137/624.19
	B	US-3,868,970	03-1975	Ayers et al.	137/625.46
	C	US-3,747,630	07-1973	Hurrell, Ronald Arthur	137/312
	D	US-3,645,142	02-1972	Turpin, Pierre	73/864.12
	E	US-3,405,734	10-1968		137/625.46
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.